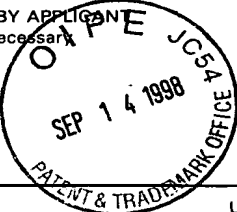
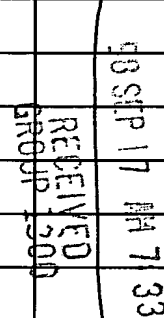


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U. S. PATENT DOCUMENTS							
EXAMINER		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE
<i>ah</i>	AA	4,452,682	06/05/84	Takata, et al.			
<i>ah</i>	AB	4,568,444	02/04/86	Nakamura, et al.			
<i>ah</i>	AC	H201	01/06/87	Yager			
<i>ah</i>	AD	4,777,019	10/11/88	Dandekar			
<i>ah</i>	AE	4,908,112	03/13/90	Pace			
<i>ah</i>	AF	4,981,572	01/01/91	Easmunt, et al.			
<i>ah</i>	AG	4,983,510	01/08/91	Lardinois, et al.			
<i>ah</i>	AH	5,019,238	05/28/91	Cormier, et al.			
<i>ah</i>	AI	5,156,810	10/20/92	Ribi			
<i>ah</i>	AJ	5,192,507	03/09/93	Taylor, et al.			
<i>ah</i>	AK	5,281,539	01/25/94	Schramm			



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	AL						
	AM						
	AN						
	AO						
	AP						

OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)		
<i>ah</i>	AQ	D.M. Kolb, R. Ullmann, T. Will, "Nanofabrication of Small Copper Clusters on Gold (111) Electrodes by a Scanning Tunneling Microscope". SCIENCE Magazine, Vol. 275, February 21, 1997, Pages 1097-1099
<i>ah</i>	AR	Leo Kouwenhoven, "Single-Molecule Transistors". SCIENCE Magazine, Vol. 275, March 28, 1997, Pages 1897-1898
	AS	

EXAMINER <i>ah Koynerala</i>	DATE CONSIDERED <i>6/16/99</i>
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* EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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U. S. PATENT DOCUMENTS							
EXAMINER		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF
<i>C.N</i>	BA	5,310,469	05/10/94	Cunningham, et al.			
<i>C.N</i>	BB	5,328,847	07/12/94	Case, et al.			
<i>C.N</i>	BC	5,332,479	07/26/94	Uenoyama, et al.			
<i>C.N</i>	BD	5,384,028	01/24/95	Ito			
<i>C.N</i>	BE	5,395,587	03/07/95	Brigham-Burke, et al.			
<i>C.N</i>	BF	5,409,583	04/25/95	Yoshioka, et al.			
<i>C.N</i>	BG	5,494,831	02/27/96	Kindler			
<i>C.N</i>	BH	5,532,128	07/02/96	Eggers, et al.			
<i>C.N</i>	BI	5,567,301	10/22/96	Stetter, et al.			
<i>C.N</i>	BJ	5,582,697	12/10/96	Ikeda, et al.			
<i>C.N</i>	BK	5,607,567	03/04/97	Yun, et al			
<i>C.N</i>	BL	5,624,537	04/29/97	Turner, et al.			
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
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	BN						
	BO						
	BP						
	BQ						
OTHER PRIOR ART (Including Author, Title, Date, Pertinent Pages, Etc.)							
	BR						
	BS						
EXAMINER <i>Albert Hognersala</i>				DATE CONSIDERED <i>6/16/99</i>			
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